

General Description

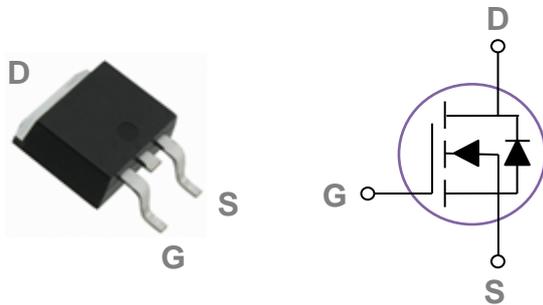
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

| | | |
|-------|-------|-----|
| BVDSS | RDSON | ID |
| 80V | 8.3mΩ | 60A |

Features

- 80V,60A, $R_{DS(ON)} = 8.3m\Omega @ V_{GS} = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

TO252 Pin Configuration



Applications

- Networking
- Load Switch
- LED applications
- Quick Charger

Absolute Maximum Ratings $T_c=25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Rating | Units |
|-----------|--|------------|---------------------|
| V_{DS} | Drain-Source Voltage | 80 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| I_D | Drain Current – Continuous ($T_c=25^\circ\text{C}$) | 60 | A |
| | Drain Current – Continuous ($T_c=100^\circ\text{C}$) | 38 | A |
| I_{DM} | Drain Current – Pulsed ¹ | 240 | A |
| EAS | Single Pulse Avalanche Energy ² | 125 | mJ |
| IAS | Single Pulse Avalanche Current ² | 50 | A |
| P_D | Power Dissipation ($T_c=25^\circ\text{C}$) | 77 | W |
| | Power Dissipation – Derate above 25°C | 0.62 | W/ $^\circ\text{C}$ |
| T_{STG} | Storage Temperature Range | -55 to 150 | $^\circ\text{C}$ |
| T_J | Operating Junction Temperature Range | -55 to 150 | $^\circ\text{C}$ |

Thermal Characteristics

| Symbol | Parameter | Typ. | Max. | Unit |
|-----------------|--|------|------|--------------------|
| $R_{\theta JA}$ | Thermal Resistance Junction to ambient | --- | 62 | $^\circ\text{C/W}$ |
| $R_{\theta JC}$ | Thermal Resistance Junction to Case | --- | 1.62 | $^\circ\text{C/W}$ |

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)
Off Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|------------|--------------------------------|---|------|------|-----------|---------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu A$ | 80 | --- | --- | V |
| I_{DSS} | Drain-Source Leakage Current | $V_{DS}=80V, V_{GS}=0V, T_J=25^\circ\text{C}$ | --- | --- | 1 | μA |
| | | $V_{DS}=64V, V_{GS}=0V, T_J=85^\circ\text{C}$ | --- | --- | 10 | μA |
| I_{GSS} | Gate-Source Leakage Current | $V_{GS}=\pm 20V, V_{DS}=0V$ | --- | --- | ± 100 | nA |

On Characteristics

| | | | | | | |
|--------------|-----------------------------------|-------------------------------|-----|-----|------|------------|
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance | $V_{GS}=10V, I_D=15A$ | --- | 6.9 | 8.3 | m Ω |
| | | $V_{GS}=4.5V, I_D=12A$ | --- | 9.8 | 12.7 | m Ω |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}, I_D=250\mu A$ | 1.2 | 1.8 | 2.5 | V |
| gfs | Forward Transconductance | $V_{DS}=10V, I_D=3A$ | --- | 9 | --- | S |

Dynamic and switching Characteristics

| | | | | | | |
|--------------|------------------------------------|--|-----|------|------|----------|
| Q_g | Total Gate Charge ^{3,4} | $V_{DS}=40V, V_{GS}=10V, I_D=30A$ | --- | 31.3 | 45 | nC |
| Q_{gs} | Gate-Source Charge ^{3,4} | | --- | 3.9 | 5.5 | |
| Q_{gd} | Gate-Drain Charge ^{3,4} | | --- | 9.5 | 15 | |
| $T_{d(on)}$ | Turn-On Delay Time ^{3,4} | $V_{DD}=40V, V_{GS}=10V, R_G=6\Omega, I_D=30A$ | --- | 22 | 33 | ns |
| T_r | Rise Time ^{3,4} | | --- | 16 | 24 | |
| $T_{d(off)}$ | Turn-Off Delay Time ^{3,4} | | --- | 40 | 60 | |
| T_f | Fall Time ^{3,4} | | --- | 31 | 47 | |
| C_{iss} | Input Capacitance | $V_{DS}=40V, V_{GS}=0V, F=1\text{MHz}$ | --- | 1720 | 2580 | pF |
| C_{oss} | Output Capacitance | | --- | 350 | 525 | |
| C_{rss} | Reverse Transfer Capacitance | | --- | 10.5 | 15 | |
| R_g | Gate resistance | $V_{GS}=0V, V_{DS}=0V, F=1\text{MHz}$ | --- | 1.1 | --- | Ω |

Drain-Source Diode Characteristics and Maximum Ratings

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------|---------------------------|---|------|------|------|------|
| I_S | Continuous Source Current | $V_G=V_D=0V, \text{Force Current}$ | --- | --- | 60 | A |
| I_{SM} | Pulsed Source Current | | --- | --- | 120 | A |
| V_{SD} | Diode Forward Voltage | $V_{GS}=0V, I_S=1A, T_J=25^\circ\text{C}$ | --- | --- | 1 | V |
| t_{rr} | Reverse Recovery Time | $V_R=50V, I_S=10A$ | --- | 40 | --- | ns |
| Q_{rr} | Reverse Recovery Charge | $di/dt=100A/\mu s, T_J=25^\circ\text{C}$ | --- | 55 | --- | nC |

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. $V_{DD}=25V, V_{GS}=10V, L=0.1\text{mH}, I_{AS}=50A, R_G=25\Omega, \text{Starting } T_J=25^\circ\text{C}$.
3. The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
4. Essentially independent of operating temperature.

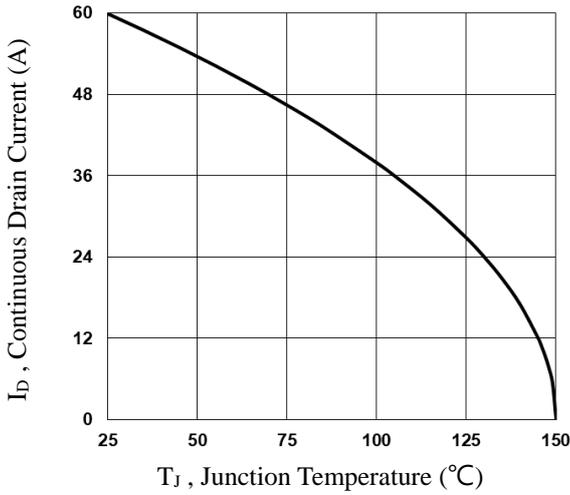


Fig.1 Continuous Drain Current vs. T_J

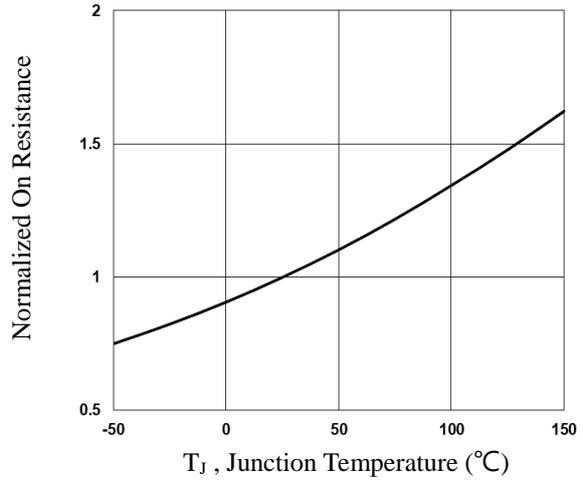


Fig.2 Normalized $R_{DS(on)}$ vs. T_J

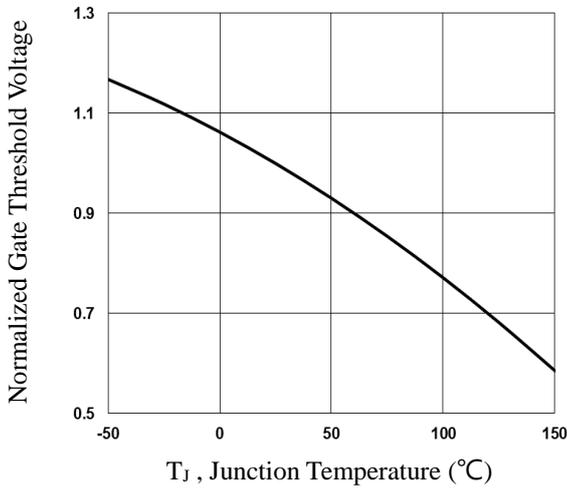


Fig.3 Normalized V_{th} vs. T_J

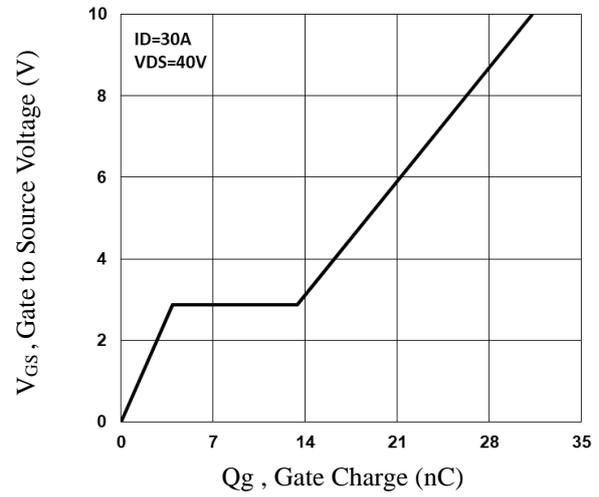


Fig.4 Gate Charge Characteristics

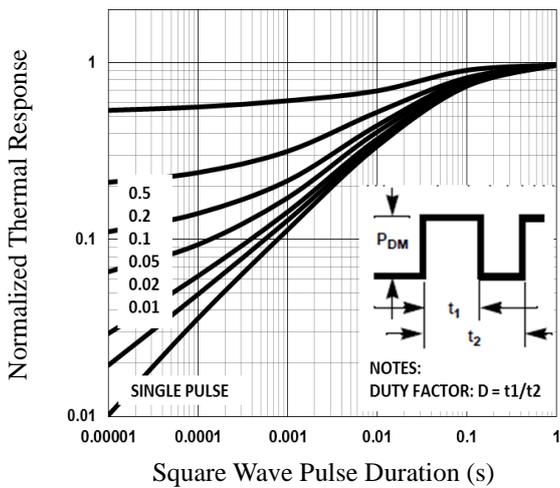


Fig.5 Normalized Transient Impedance

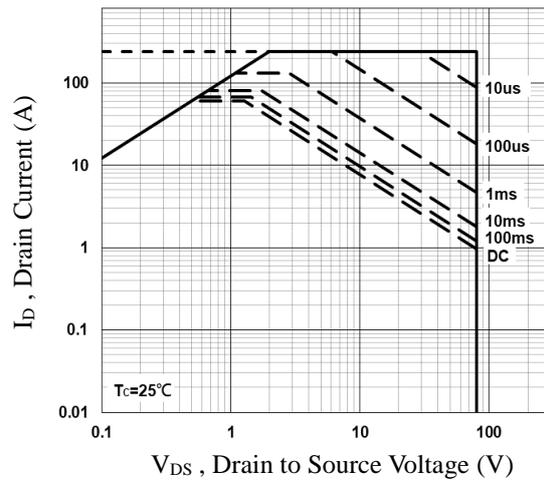


Fig.6 Maximum Safe Operation Area

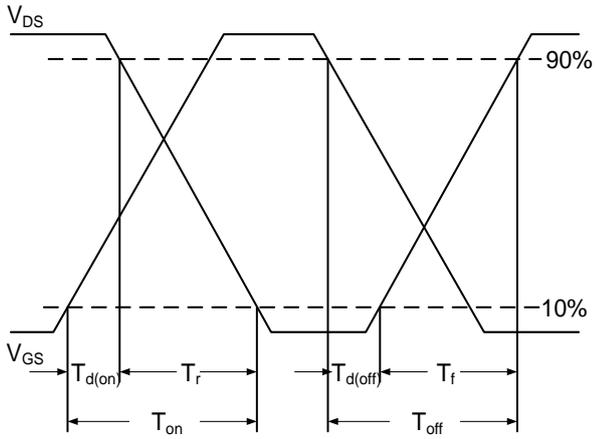
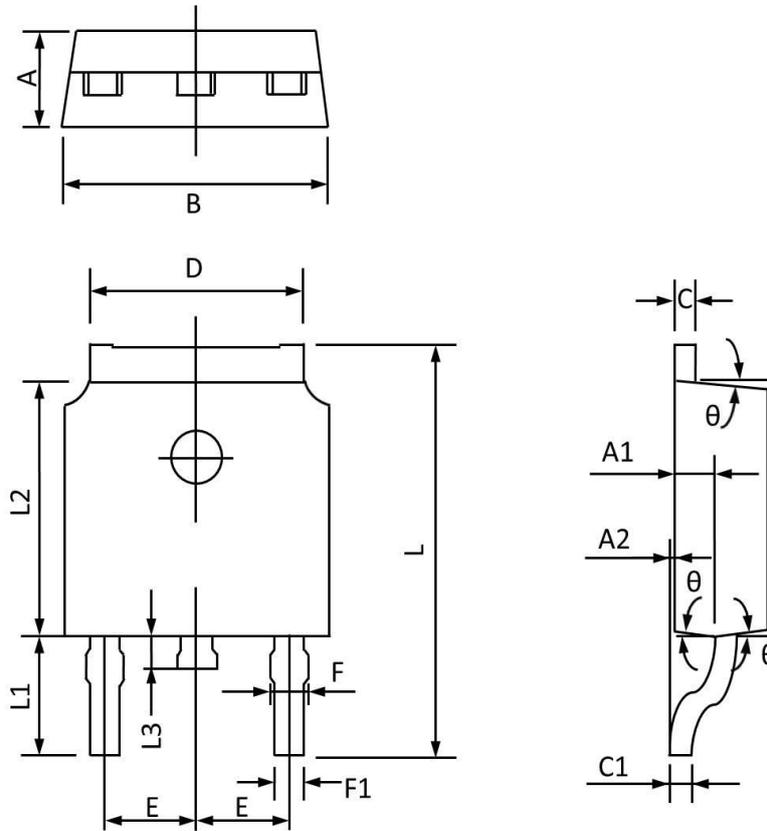


Fig.7 Switching Time Waveform



Fig.8 Gate Charge Waveform

TO252 PACKAGE INFORMATION



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|----------|---------------------------|-------|----------------------|-------|
| | MAX | MIN | MAX | MIN |
| A | 2.450 | 2.150 | 0.096 | 0.085 |
| A1 | 1.200 | 0.910 | 0.047 | 0.036 |
| A2 | 0.150 | 0.000 | 0.006 | 0.000 |
| B | 6.800 | 6.300 | 0.268 | 0.248 |
| C | 0.580 | 0.350 | 0.023 | 0.014 |
| C1 | 0.550 | 0.380 | 0.022 | 0.015 |
| D | 5.500 | 5.100 | 0.217 | 0.201 |
| E | 2.390 | 2.000 | 0.094 | 0.079 |
| F | 0.940 | 0.600 | 0.037 | 0.024 |
| F1 | 0.860 | 0.500 | 0.034 | 0.020 |
| L | 10.400 | 9.400 | 0.409 | 0.370 |
| L1 | 3.000 | 2.400 | 0.118 | 0.094 |
| L2 | 6.200 | 5.300 | 0.244 | 0.209 |
| L3 | 1.200 | 0.600 | 0.047 | 0.024 |
| θ | 9° | 3° | 9° | 3° |